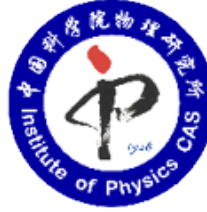


5th Swiss-Sino Workshop Fundamental and Applied Researches Using Large Facilities



Contribution ID: 49

Type: not specified

Probing the ground state oxygen holes and the metal-insulator transition in strained rare earth nickelate films with Resonant Inelastic X-ray Scattering

Tuesday, 5 May 2015 16:10 (25 minutes)

Presenter: Dr SCHMITT, Thorsten (Paul Scherrer Institut)